Search Notes

Application/Control N	o. Applicant(s)/Patent under Reexamination
10/043,368	FARWELL, WILLIAM D.
Examiner	Art Unit
Tse Chen	2116

SEARCHED						
Class	Subclass	Date	Examiner			
713	300	12/6/04	756			
713	300	4/7/05	TSE			
713	310	4/7/05	TSE			
·						

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
713	300	4/1/05	TSE	
713	310	4/7/05	TSE	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (R=PORT)	12/6-	TSE	
	12/7/64	126	
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